

Description

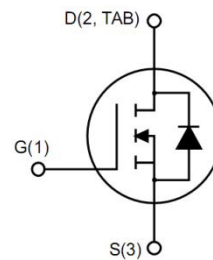
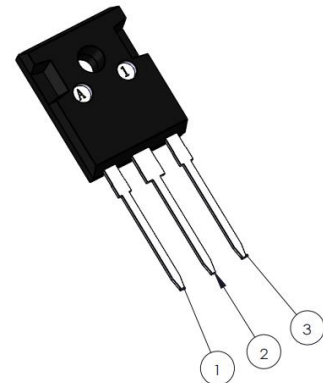
Silicon Carbide (SiC) MOSFET use a completely new technology that provide superior switching performance and higher reliability compared to Silicon. In addition, the low ON resistance and compact chip size ensure low capacitance and gate charge. Consequently, system benefits include highest efficiency, faster operating frequency, increased power density, reduced EMI, and reduced system size.

Features

- High Speed Switching with Low Capacitances
- High Blocking Voltage with Low RDS(on)
- Easy to parallel and simple to drive
- ROHS Compliant, Halogen free

Application

- EV Charging
- High Voltage DC/DC Converters
- Switch Mode Power Supplies
- Power Factor Correction Modules



Ordering Information

Part Number	Marking	Package	Packaging
ASC30N1200MT3	ASC30N1200MT3	TO-247	Tube

Absolute Maximum Ratings(Tc=25°C)

Symbol	Parameter	Value	Unit
V _{DS}	Drain-Source Voltage	1200	V
I _D	Drain Current(continuous)at Tc=25°C	32	A
I _D	Drain Current(continuous)at Tc=100°C	23	A
I _{DM}	Drain Current (pulsed)	80	A
V _{GS}	Gate-Source Voltage	-10/+22	V
P _D	Power Dissipation T _c = 25°C	145	W
T _J , T _{stg}	Junction and Storage Temperature Range	-55 to +150	°C

Electrical Characteristics(T_J = 25°C unless otherwise specified)
Typical Performance-Static

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
BV _{DS}	Drain-source Breakdown Voltage	I _D =250uA, V _{GS} =0V	1200			V
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =1200V, V _{GS} =0V, T _J =25°C			100	uA
I _{GSS}	Gate-body Leakage Current	V _{DS} =0V ; V _{GS} =-10 to 20V			250	nA
V _{GS(th)}	Gate Threshold Voltage	V _{DS} = V _{GS} , I _D =5mA	2	3	4	V
V _{GS(on)}	Recommended turn-on Voltage	Static		20		V
V _{GS(off)}	Recommended turn-off Voltage			-5		V
R _{DS(on)}	Static Drain-source On Resistance	V _{GS} =20V, I _D =20A		80	100	mΩ
		V _{GS} =20V, I _D =20A T _J =150°C		122		mΩ

Typical Performance-Dynamic

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
C _{iss}	Input Capacitance	V _{DS} =1000V, f=1MHz, V _{AC} =25mV		1590		pF
C _{oss}	Output Capacitance			63		pF
C _{rss}	Reverse Transfer Capacitance			3.9		pF
g _{fs}	Transconductance	V _{DS} =20V, I _D =20A		12		S
E _{oss}	Coss Stored Energy	V _{DS} =1000V, f=1MHz		35.7		μJ
E _{on}	Turn-On Energy (Body Diode)	V _{DS} =800V, V _{GS} =-5V/20V, I _D =20A, L=150μH T _J =150°C		984		μJ
E _{off}	Turn-Off Energy (Body Diode)			165		μJ
Q _g	Total Gate Charge	V _{DS} =800V, V _{GS} =-5V/20V, I _D =20A		72		nC
Q _{gs}	Gate-source Charge			21		nC
Q _{gd}	Gate-Drain Charge			22		nC
R _{G(int)}	Internal Gate Resistance	f=1MHz, V _{AC} =25mV		3		Ω
t _{d(on)}	Turn-on Delay Time	V _{DS} =800V, V _{GS} =-5V/20V, I _D =20A, L=150 μH R _{ext} =2.5Ω		58		ns
t _r	Rise Time			20.5		ns
t _{d(off)}	Turn-off Delay Time			35		ns
t _f	Fall Time			17.8		ns

Typical Performance-Reverse Diode(T_J = 25°C unless otherwise specified)

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
V _{FSD}	Forward Voltage	V _{GS} =0V, I _F =10A, T _J =25°C		4.8	6	V
		V _{GS} =0V, I _F =10A, T _J =150°C		4.2	6	V
I _S	Continuous Diode Forward Current	V _{GS} =0V, T _C =25°C		27		A
t _{rr}	Reverse Recovery Time	V _{GS} =-5 V, I _F =20 A, V _R =800 V, di/dt=900 A/μs, T _J =150°C		36		nS
Q _{rr}	Reverse Recovery Charge			297		nC
I _{rrm}	Peak Reverse Recovery Current			15.5		A

Thermal Characteristics

Symbol	Parameter	Value.	Unit
R _{θJC}	Thermal Resistance, Junction-to-Case	0.86	°C/W
R _{θJA}	Thermal Resistance, Junction-to-Ambient	40	°C/W

The values are based on the junction-to case thermal impedance which is measured with the device mounted to a large heat sink assuming maximum junction temperature of T_J(max)=150°C

Electrical Characteristics

Fig1. Output characteristics ($T_J = 25^\circ\text{C}$)

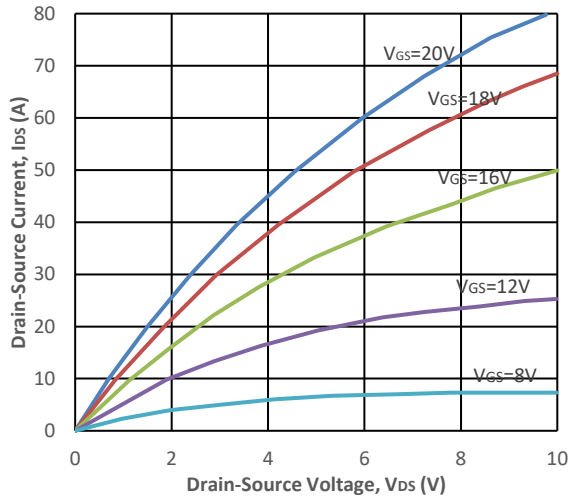


Fig2. Output characteristics ($T_J = 150^\circ\text{C}$)

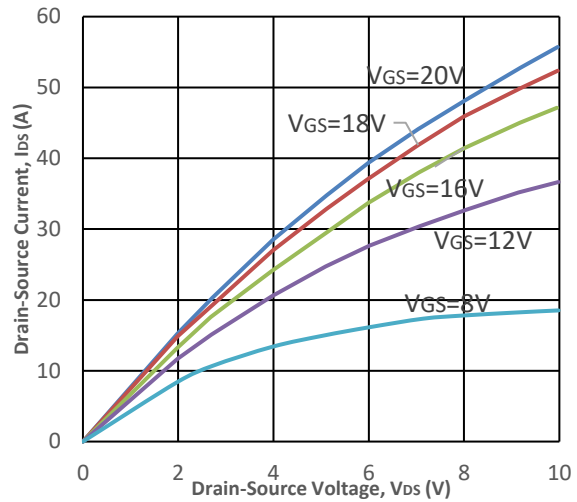


Fig3. Normalized On-Resistance vs. Temperature

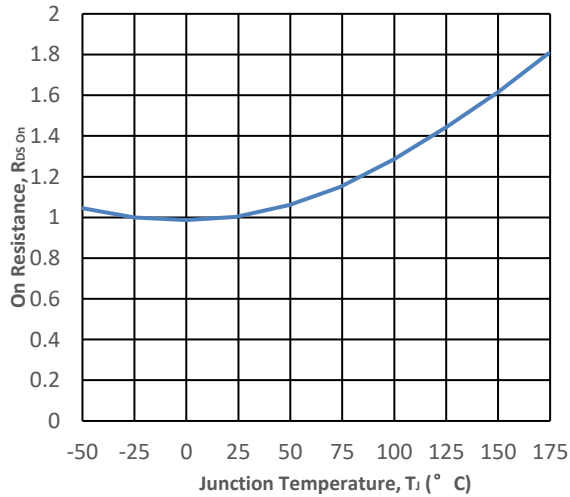


Fig4. On-Resistance vs. Temperature

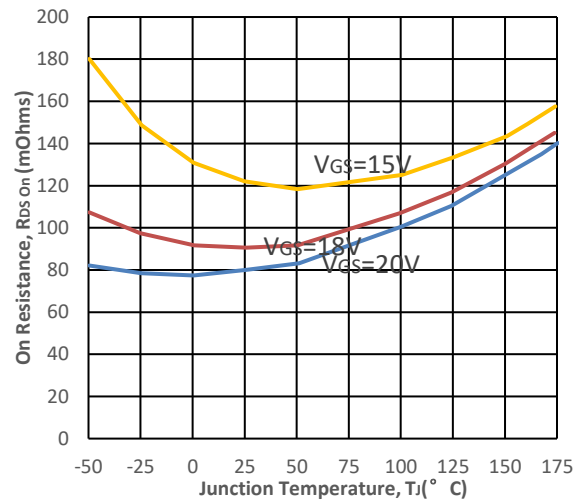


Fig5. Transfer Characteristic

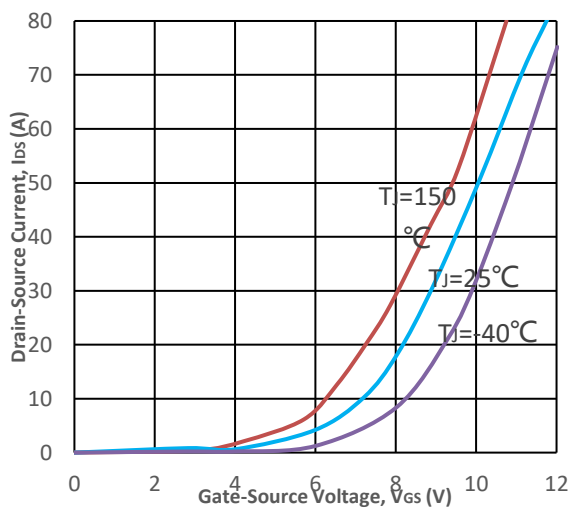


Fig6. Body Diode Characteristic at 25°C

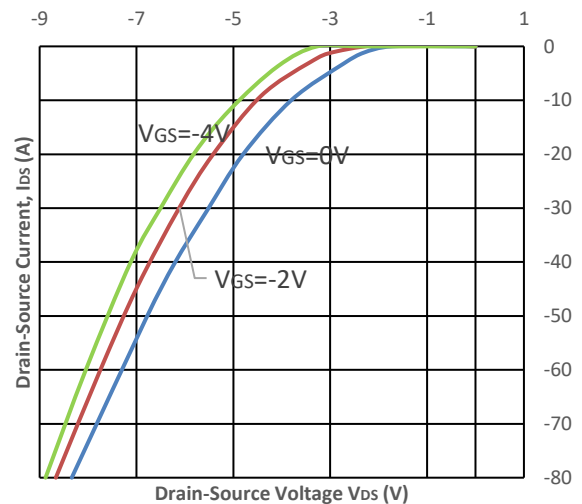


Fig7. Threshold Voltage vs. Temperature

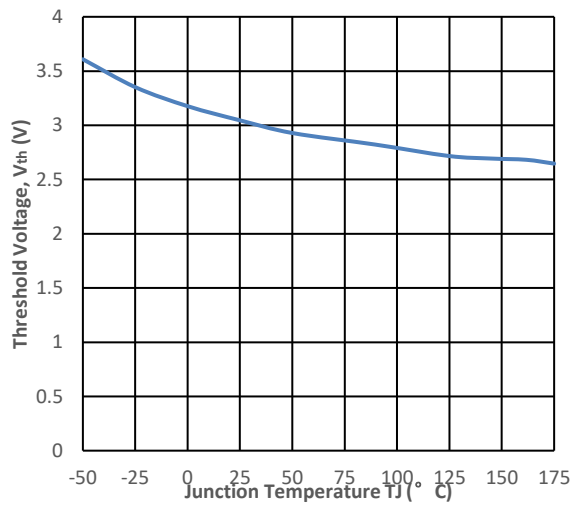


Fig8. Gate Charge Characteristics

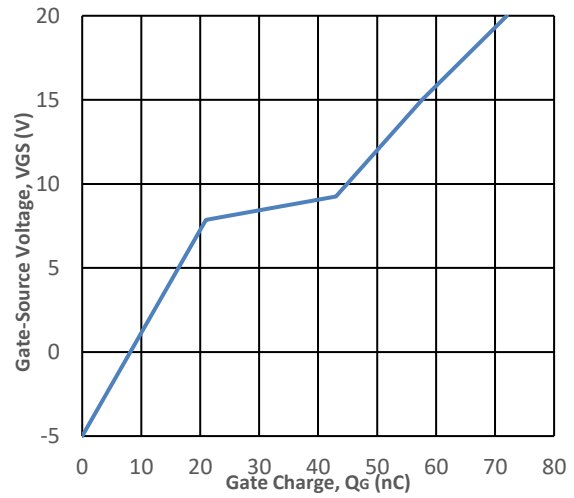


Fig9. 3rd Quadrant Characteristic at 25 °C

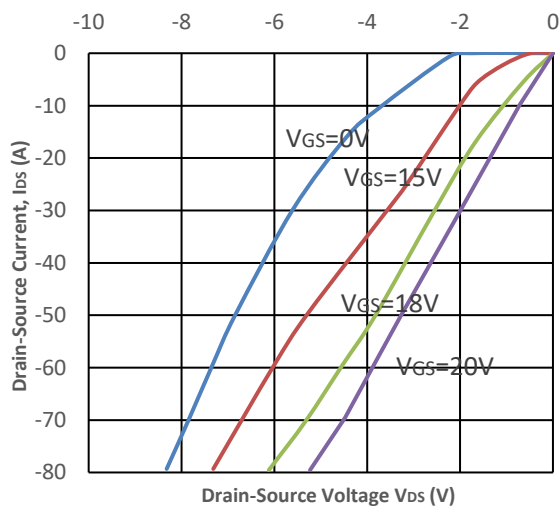


Fig10. Output Capacitor Stored Energy

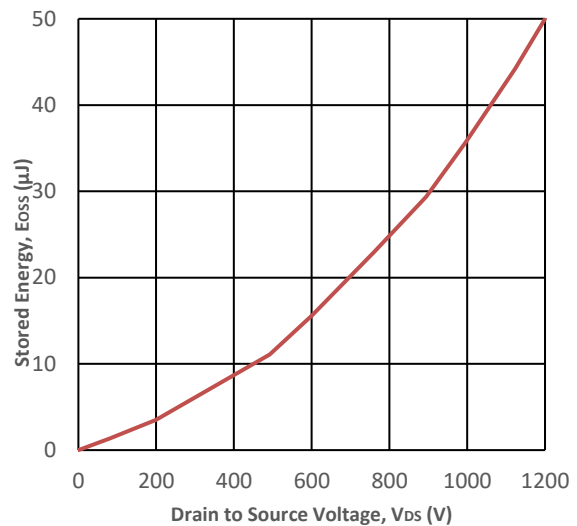


Fig11. Capacitances vs. Drain-Source

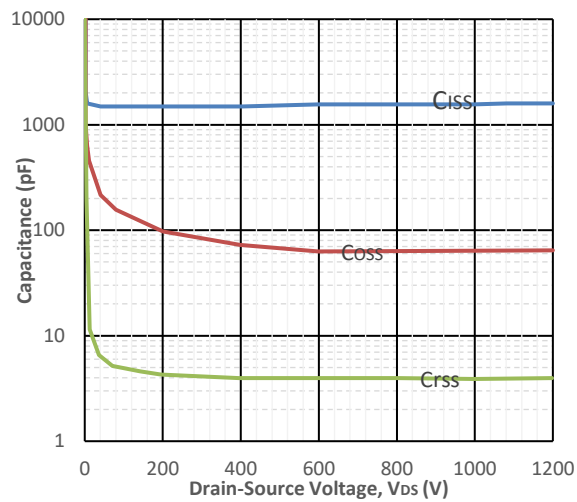


Fig12. Max Power Dissipation Derating Vs Tc

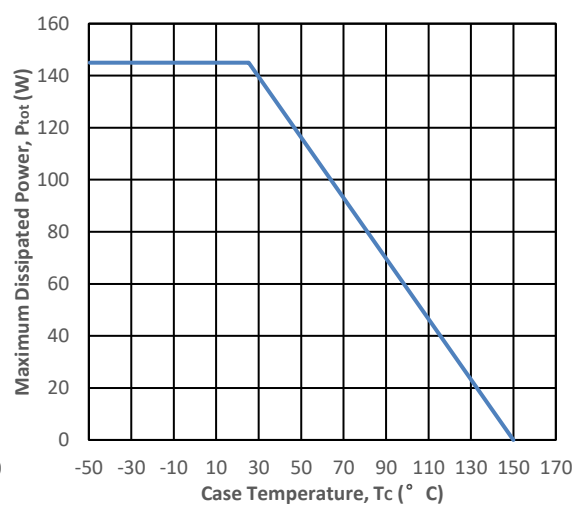


Fig13. Switching Energy vs. Drain Current

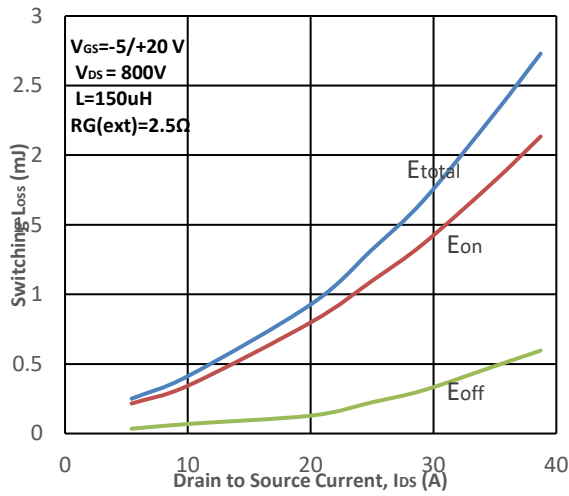


Fig14. Switching Energy vs. $R_{G(ext)}$

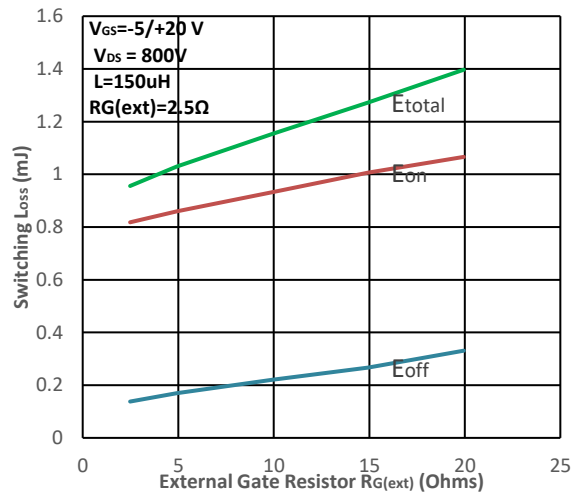


Fig15. Switching Energy vs. Temperature

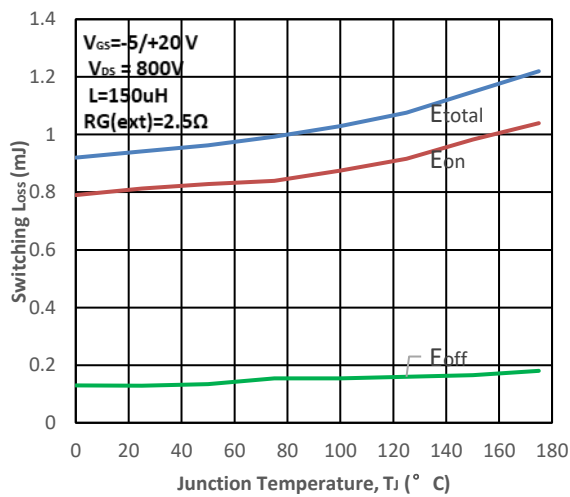


Fig16. Switching Times vs. $R_{G(ext)}$

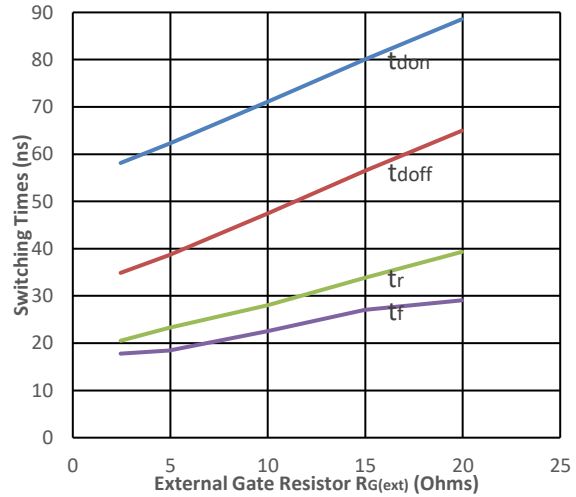


Fig17. Transient Thermal Impedance

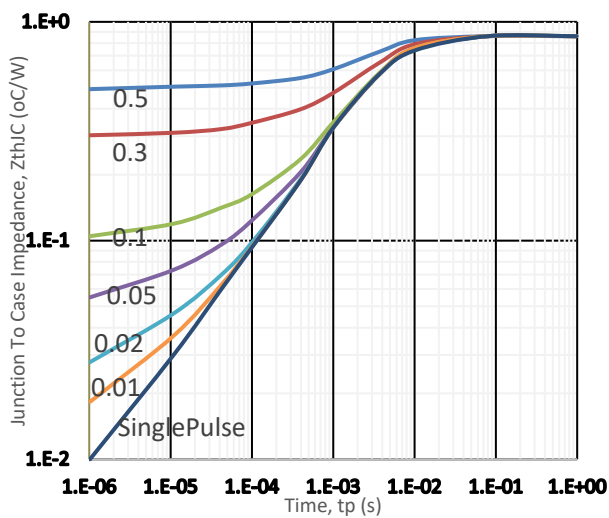
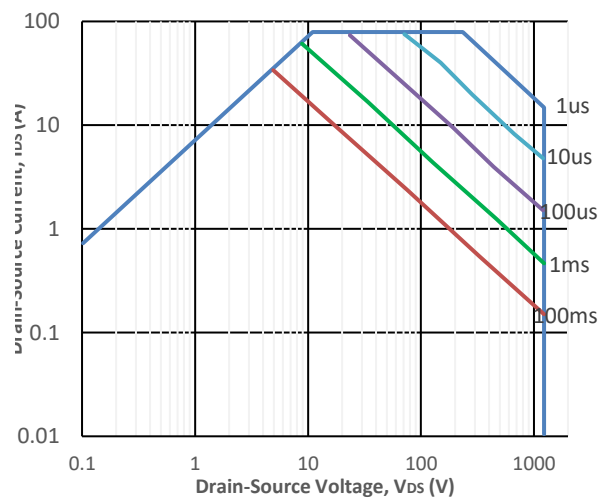
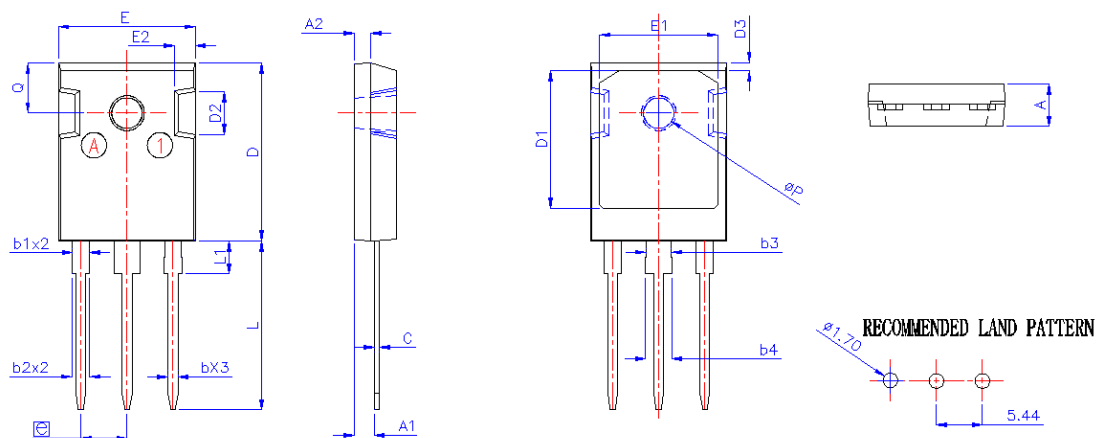


Fig18. Safe Operating Area



Package Drawing:

Dimensions (UNIT: mm)

SYMBDLS	DIMENSIONS IN MILLIMETERS			DIMENSIONS IN INCHES		
	MIN	NOM	MAX	MIN	NOM	MAX
A	4.90	5.00	5.10	0.193	0.197	0.201
A1	2.31	2.42	2.52	0.091	0.095	0.099
A2	1.90	2.00	2.10	0.075	0.079	0.083
b	1.16	1.22	1.27	0.046	0.048	0.050
b1	1.96	2.02	2.07	0.079	0.080	0.081
b2	2.03	2.07	2.10	0.080	0.0815	0.083
b3	2.96	3.02	3.07	0.117	0.119	0.121
b4	3.03	3.07	3.1	0.119	0.120	0.122
C	0.59	0.62	0.66	0.023	0.024	0.026
D	20.90	21.00	21.10	0.823	0.827	0.831
D1	15.96	16.26	16.56	0.628	0.640	0.652
D2	4.3			4.3		
D3	0.8	0.95	1.1	0.031	0.037	0.043
e	5.44 BSC				0.214 BSC	
E	15.95	16.15	16.35	0.628	0.636	0.644
E1	13.82	14.02	14.26	0.544	0.552	0.561
E2	4.3				0.169	
L	19.72	19.92	20.12	0.776	0.784	0.792
L1	—	—	3.86	—	—	0.152
Q	5.95 BSC			0.234BSC		
ØP	3.55	3.60	3.70	0.140	0.142	0.146